



SHEET 1 OF 1

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SEP 15 2008
USPTO
PATENT & TRADEMARK OFFICEINFORMATION DISCLOSURE
CITATION IN AN
APPLICATIONATTY. DOCKET NO.
049480-0065

SERIAL NO.

APPLICANT
Jack C. RAINS, Jr., et al.FILING DATE
October 21, 2005GROUP
Not yet assigned

(PTO-1449)

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if Known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	US	2002/0064043	5/30/2002	Ariga et al.	
	US	2003/0193816	10/16/2003	Rahn	
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	
		"Developmental Product Technical Data Bulletin" Ferro Corporation-Specialty Plastics Group, Filled and Reinforced Plastics Division, Evansville, IN	
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EXAMINER		DATE CONSIDERED	

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**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION**

(PTO-1449)

U.S. PATENT DOCUMENTS

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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code & Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No

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1 Applicant's unique citation designator number is **1**. 2 Application is filed in English language. Translation is attached.



SHEET 1 OF 1

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Substitute for form 1449/PTO)

ATTY. DOCKET NO.
049480-0065SERIAL NO.
10/555,094APPLICANT
Jack C. RAINS, Jr.; et al.FILING DATE
November 02, 2005GROUP
2875**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (If Known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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U.S. Office Action Issued in U.S. Patent Application No. 11/233,036, dated May 30, 2007.

Arby EXAMINER 1/15/08 DATE CONSIDERED

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